<u>Claims</u>

What is claimed is:

	1	1.	A calibration database stored in a computer readable medium, said
١.	2		database comprising:
וע			\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \
A l	3		(a) information elements describing at least one functional
,	4		performance characteristic of respective structural features on a
	5		substrate, and
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## #1	6		(b) information elements describing feedback from said respective
	7		structura features as a function of position over each of said
	8		respective structural features.
O	1	2.	The calibration database of claim 1 further comprising:
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T.	2		(c) information elements describing physical analysis of each of said
	3		respective structural features.
	1	3.	The calibration database of claim 1 wherein said feedback comprises
	2		secondary electron emission from said structural features upon exposure
	3		to a scanning electron beam.
	1	4.	The calibration database of claim 1 wherein said structural features are
	2		holes in a resist layer on said substrate.
	1	5.	The calibration database of claim 4 wherein said functional performance
	2		characteristic is a response of each respective hole to an etching protocol

	1	6.	A met	thod for evaluation of target structural features on a substrate, said
- 1 .	2		metho	od comprising:
WA CAN	3		(a)	providing a calibration database comprising:
	4 5 6 7 8 9 10			 (i) information elements selected from the group consisting of (A) information elements describing a functional performance characteristic of respective reference structural features on a substrate, and (B) information elements describing a physical characteristic of each of said respective reference structural features, or both types of information elements, and (ii) information elements describing feedback from said respective reference structural features as a function of position over each of said respective reference structural
	13 14			features,
Front	15 16 17 18 19		(b)	providing at least one weighting function as a function of position over each of said respective reference structural features and at least one correlation function as a function of position over each of said respective reference structural features, wherein a plurality of weighting functions and/or correlation functions is provided,
	20 21 22 23		(c)	determining a combination of weighting function and correlation function from said provided which provide a desired degree of correlation between said information elements (i) and (ii) for respective reference structural features,

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(d)	providing	information elements describing feedback from said
	target str	uctural features as a function of position over each of said
	respective	target structural features on said substrate, and

- (e) applying said combination of weighting function and correlation function to said target structural feature information elements to predict said functional performance characteristic of respective target structural features and/or to describe said physical characteristic of respective target structural features.
- 7. The method of claim 6 wherein a plurality of weighting functions and a plurality of correlation functions are provided in step (b).
- 8. The method of claim 6 wherein said weighting functions are selected from the group consisting of continuous functions and discontinuous functions.
- The method of claim 6 wherein a value of said weighting function of said determined combination of step (c) is multiplied with a value of a respective information element in step (e).
- 1 10. The method of claim 6 wherein said calibration database includes
 2 information elements describing a functional performance characteristic of
 3 respective reference structural features on a substrate, and said
 4 functional performance characteristic is predicted in step (e).
- 1 11. The method of claim 10 wherein said functional performance 2 characteristic is the etchability across said target feature.

	1	12.	The method of claim 6 wherein said structural features are holes	in a
, L	2		esist layer on said substrate.	
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KI	1	13.	The method of claim 12 wherein said functional performance	
W	2		characteristic is a response of each respective hole to an etching	g protocol.
	1	14.	The method of claim 6 wherein all of said information elements a	are
	2		embodied in a computer-readable medium and steps (c) and (e)	are
	3		performed using a computer.	
10	1	15.	The method of claim 6 wherein said feedback of steps (a) and (e	
	2		comprises secondary electron emission from said structural feat	ures upon
	3		exposure to a scanning electron beam.	
41 41				
g 1_1	1	16.	The method of claim 6 wherein steps (c) and (e) include perform	nance of
	2		linear regression analysis.	
			a un la completa de torget etructural features en a substr	ate said
f.i.	1	17.	A method for evaluation of target structural features on a substr	ato, cara
g some	2		method comprising:	
	3		(a) providing information elements describing feedback from	said
	4		target structural features as a function of position over ea	ach of said
	5		respective target structural features on said substrate,	
	6		(b) applying a combination of a weighting function and a cor	relation
	7		function to said target structural feature information elem	ents to
	8		predict a functional performance characteristic of respec	
	9		structural features and/or to describe a physical characte	
	10		respective target structural features.	

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1	The method of claim 17 wherein a value of said weighting function is
2	multiplied with a value of a respective information element in step (b)

- 19. The method of claim 17 wherein a functional performance characteristic is predicted in step (b).
- 1 20. The method of claim 19 wherein said functional performance 2 characteristic is the etchability across said target feature.
- 1 21. The method of claim 17 wherein said structural features are holes in a resist layer on said substrate.
- 1 22. The method of claim 21 wherein said functional performance 2 characteristic is a response of each respective hole to an etching protocol.
- The method of claim 17 wherein all of said information elements are embodied in computer-readable media and steps (c) and (e) are performed using a computer.
- The method of claim 17 wherein said feedback comprises secondary electron emissions from said structural features upon exposure to a scanning electron beam.
- 1 25. A system for evaluation of target structural features on a substrate, said system comprising:
- (a) a calibration database in a computer-readable medium, said
 database comptising:
 - (i) information elements selected from the group consisting of



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information elements describing a functional performance characteristic of respective reference structural features on a substrate and information elements describing physical analysis of each of said respective reference structural features, and

- (ii) information elements describing feedback from said respective structural features as a function of position over each of said respective reference structural features,
- (b) information elements in a computer-readable medium corresponding to at least one weighting function as a function of position over each of said respective reference structural features, and at least one correlation function as a function of position over each of said respective reference structural features, wherein a plurality of weighting functions and/or correlation functions is provided,
- (c) means for determining a combination of weighting function and correlation function from said provided which provide a desired degree of correlation between said information elements (i) and (ii) for respective reference structural features,
- (d) information elements in a computer-readable medium describing feedback from said target structural features as a function of position over each of said respective target structural features on said substrate,
- (e) means for applying said combination of weighting function and

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correlation	n function to said target structural feature information
elements	to predict said functional performance characteristic of
respective	target structural features and/or to describe said
physical c	naracteristic of respective target structural features.

- 26. The system of claim 25 wherein said means (c) comprises executable code stored in a computer readable medium and a computer capable of executing said code.
- 27. The system of claim 25 wherein said means (e) comprises executable code stored in a computer readable medium and a computer capable of executing said code.
- 28. An apparatus for evaluation of target structural features on a substrate, said apparatus comprising:
 - (a) information elements in a computer-readable medium describing feedback from said target structural features as a function of position over each of said respective target structural features on said substrate.
 - (b) means for applying a combination of weighting function and correlation function to said target structural feature information elements to predict a functional performance characteristic of respective target structural features and/or to describe a physical characteristic of respective target structural features.
- 29. The apparatus of claim 28 further comprising means for obtaining said information elements.



30.	The apparat	μs of claim 29 wherein said means for obtaining said
	information e	lements includes a scanning electron beam.

- 31. A computer program stored in a computer-readable medium, said program performing a method of evaluating target structural features on a substrate, said method comprising:
 - (a) creating a calibration database comprising:
 - (i) information elements selected from the group consisting of

 (A) information elements describing a functional performance characteristic of respective reference structural features on a substrate, and (B) information elements describing a physical characteristic of each of said respective reference structural features, or both types of information elements, and
 - (ii) information elements describing feedback from said respective reference structural features as a function of position over each of said respective reference structural features.
 - (b) providing at least one weighting function as a function of position over each of said respective reference structural features and at least one correlation function as a function of position over each of said respective reference structural features, wherein a plurality of weighting functions and/or correlation functions is provided,
 - (c) determining a combination of weighting function and correlation

	21			function from said provided which provide a desired degree of
ما ۵	22			correlation between said information elements (i) and (ii) for
ANN AND	23			respective reference structural features,
•	24		(d)	obtaining information elements describing feedback from said
	25			target structural features as a function of position over each of said
	26			respective target structural features on said substrate, and
	27		(e)	applying said combination of weighting function and correlation
	28			function to said target structural feature information elements to
	29			predict said functional performance characteristic of respective
	30			target structural features and/or to describe said physical
	31			characteristic of respective target structural features.
			•	mputer program stored in a computer-readable medium, said
	1	32.		ram performing a method of evaluating target structural features on a
	2		proai	am berrorming a method of evaluating target structural roatalog on a
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The state of the s	3			trate, said method comprising:
				trate, said method comprising: obtaining information elements describing feedback from said
	3		subs	trate, said method comprising: obtaining information elements describing feedback from said target structural features as a function of position over each of said
	3		subs	trate, said method comprising: obtaining information elements describing feedback from said
melle flower of the state of th	3 4 5		subs	trate, said method comprising: obtaining information elements describing feedback from said target structural features as a function of position over each of said
	3 4 5 6		subs	obtaining information elements describing feedback from said target structural features as a function of position over each of said respective target structural features on said substrate,
	3 4 5 6		subs	obtaining information elements describing feedback from said target structural features as a function of position over each of said respective target structural features on said substrate, applying a combination of a weighting function and a correlation
	3 4 5 6 7 8		subs	obtaining information elements describing feedback from said target structural features as a function of position over each of said respective target structural features on said substrate, applying a combination of a weighting function and a correlation function to said target structural feature information elements to